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Texas Instruments High Rel Products Reliability Report

Device Type/Device Family:OPA211SHKJ/OPA211SHKQPackage Type:8CFP/8CSOICWafer Fabrication Facility:Ti FreisingAssembly/Test Facility:Millennium MicrotechReporting Period:04/12

Biased Life Test

| | JESD22-A108 210°C / 1000 hours |
|--------------------------|-----------------------------------|
| Sample Size: | 45 |
| Rejects: | |
| Activation Energy (eV): | .5 |
| Equivalent Device Hours: | 45000 |
| Failure Rate (FIT)*: | 20491 |

* 60% confidence level of random failure rate during nominal 1000 hour life based on test sample size. This not based on wear out failure mechanisms which will begin to affect above the 1000 hr test limit.

| Group B Tests (Weekly by Package Family) | | | |
|---|------------------------------------|---|---------------------|
| Description B1 | Condition | Referenced Method | Sample Size/Rejects |
| Resistance to Solvents B2 | | Mil Std 883 Method 2015 | 3/0 |
| Bond strength | Test condition F (FC) | Mil Std 883 Method 2011/2019/2027 | 22/0-3/0 |
| B3 | | | |
| Solderability | Soldering temperature of 245C±5 | Mil Std 883 Method 2003 | 22/0 |
| Group C Test (Per 3 Month Period by Family) | | | |
| Description C1 | Condition | Referenced Method | Sample Size/Rejects |
| Steady-state life test | 125C/1000Hrs 4.6V | Mil Std 883 Method 1005 | |
| End point electrical | | | 45/0 |



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| Description | Group D Tests (Ann Condition | ually by Package Family) Referenced Method | Sample Size/Rejects | |
|---|---------------------------------|--|---------------------|---|
| D1 Physical Dimensions | | Mil Std 883 Method 2016 | 15/0 | * |
| D2 Lead Integrity | | Mil Std 883 Method 2004 & 2028 | 45/0 | * |
| Seal(Fine and Gross) | | Mil Std 883 Method 1014 | 45/0 | * |
| D3 | | | | |
| Thermal Shock | -65°C to +150°C 15 cycles | Mil Std 883 Method 1011 | | |
| Temperature Cycle | -65°C to +150°C 100 cycles | Mil Std 883 Method 1010 | | * |
| Moisture Resistance | | Mil Std 883 Method 1004 | | |
| Seal(Fine and Gross) | | Mil Std 883 Method 1014 | | * |
| Visual examination | | Mil Std 883 | | |
| End point electrical D4 | | Method 1004 &1010 | 15/0 | * |
| Mechanical Shock | | Mil Std 883 | | |
| Variable Freq Vibration Constant acceleration | | Method 2002 Mil Std 883 Method 2007 Mil Std 883 | | * |
| Seal | | Method 2001 Mil Std 883 Method 1014 | | * |
| Visual Examination | | Mil Std 883 Method 2009 | | |
| End point electrical D5 | | | 15/0 | * |
| Salt Atmosphere | | Mil Std 883 Method1009 | | |
| Seal | | Mil Std 883 Method 1014 | | * |
| Visual Examination | | Mil Std 883 Method 1009 | 15/0 | |
| D6 | | | | |
| Internal Water Vapor | | Mil Std 883 Method1018 | 3/0 | |
| D7 | | Motiouroro | | |
| Adhesion of Lead Finish | | Mil Std 883 Method 2025 | 15/0 | |
| | | | | |

Supplemental Device Characteristics

| Die Revision: Master Die: | K RO211PHKAIM | Assembly Site: Package Type: | MMT HKJ/HKQ |
|------------------------------|------------------|---------------------------------|----------------|
| Wafer Fab: | FFAB | Pin Count: | 8 |
| Fab Technology: | BiCom | Mold Compound: | Ceramic |
| Fab Process: | BiCom3HV | Mount Compound: | JM7000 |
| Process Code: | BiCom-HV | Bond: | AI |
| Passivation: | Nitride | Lead Composition: | Kovar |
| Lead Finish: | Au | | |

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